### Guideline for

Data Entry, Managing **Bibliographic Record and Cite While You Write** 



# Introduction

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# Function

 To create and organize bibliographic references
 To collect and compile bibliographic information from various resource.

To produce complete references according to required citation style or format.



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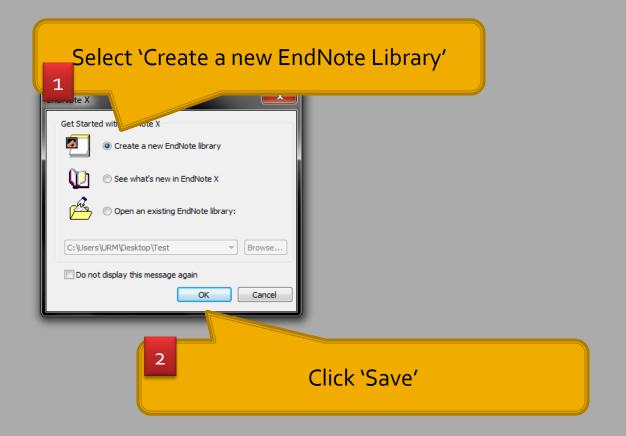


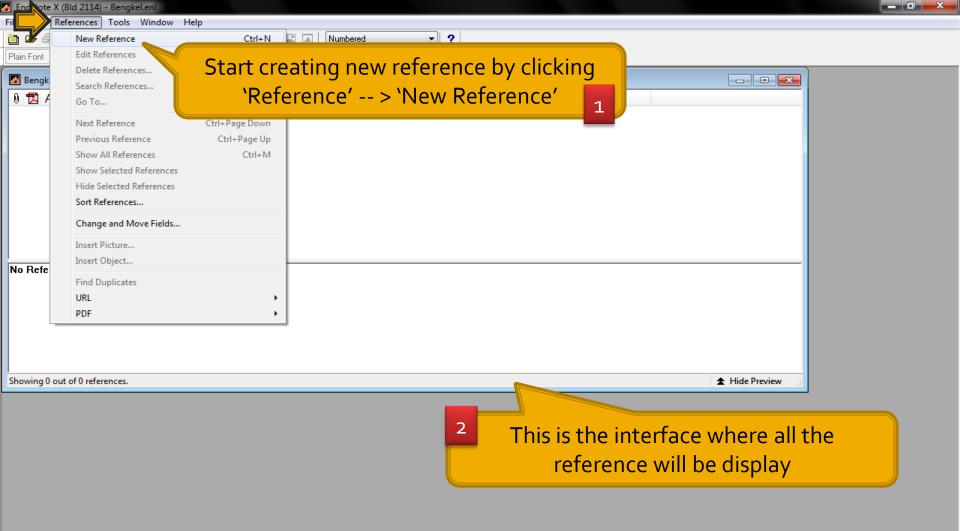
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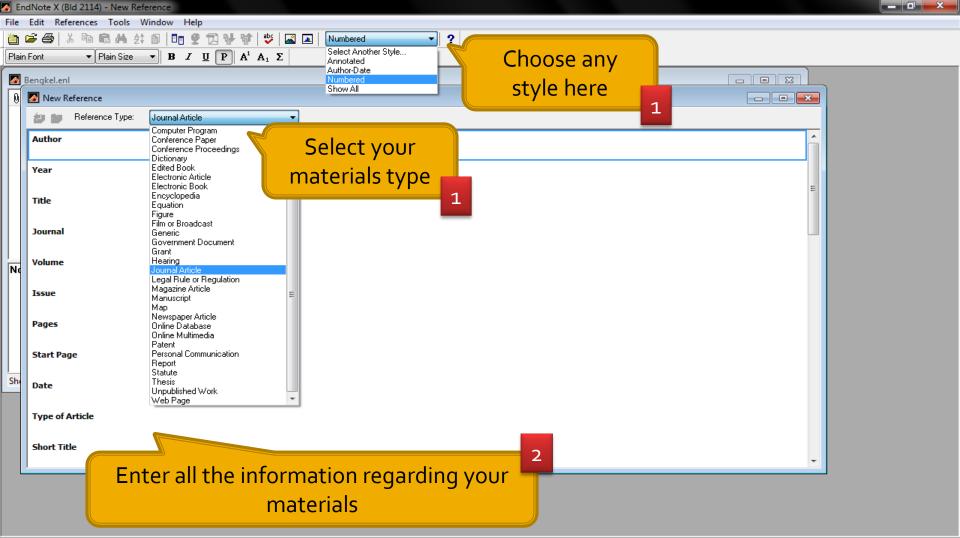
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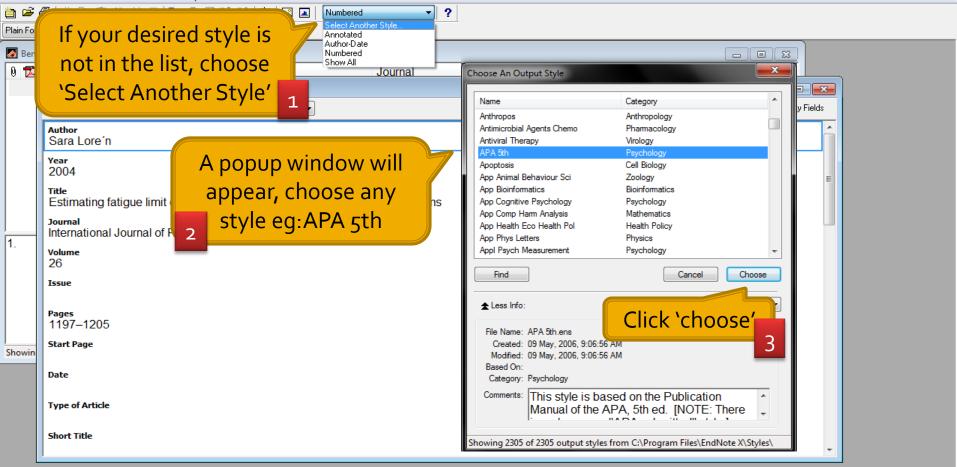
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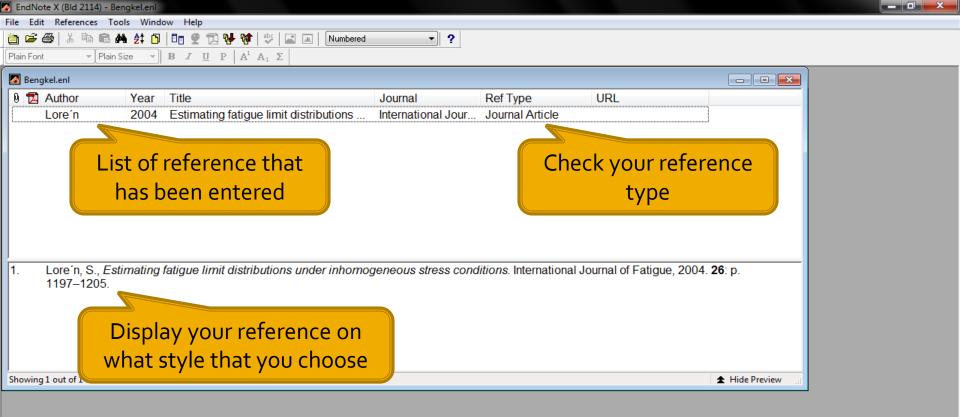




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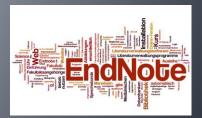


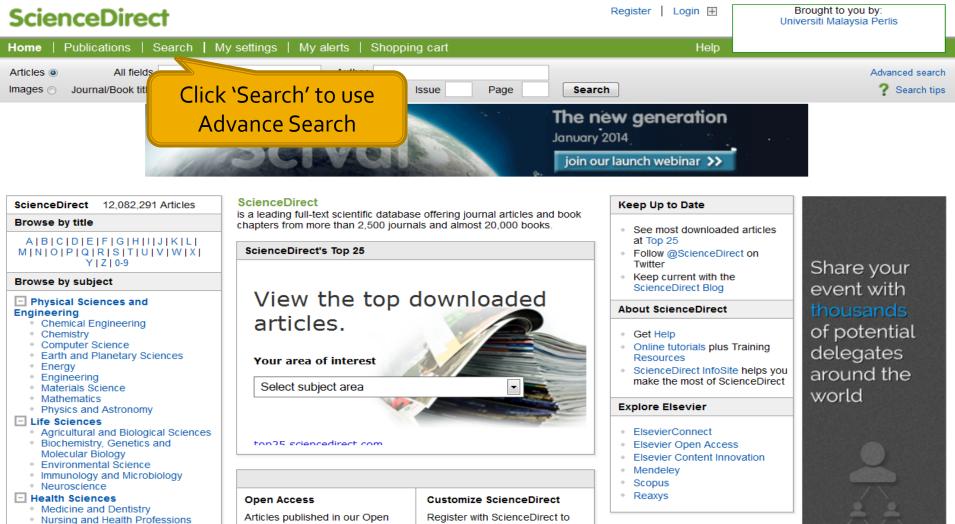
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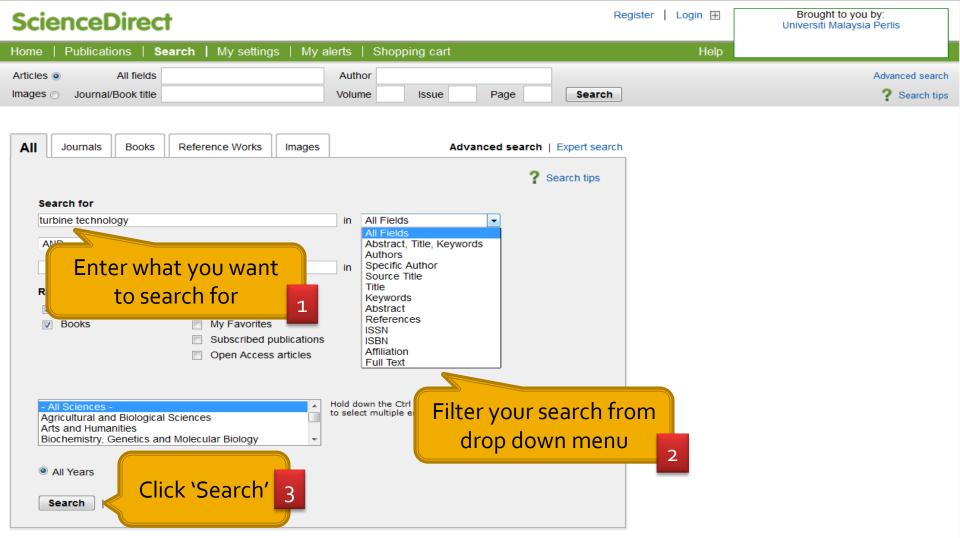


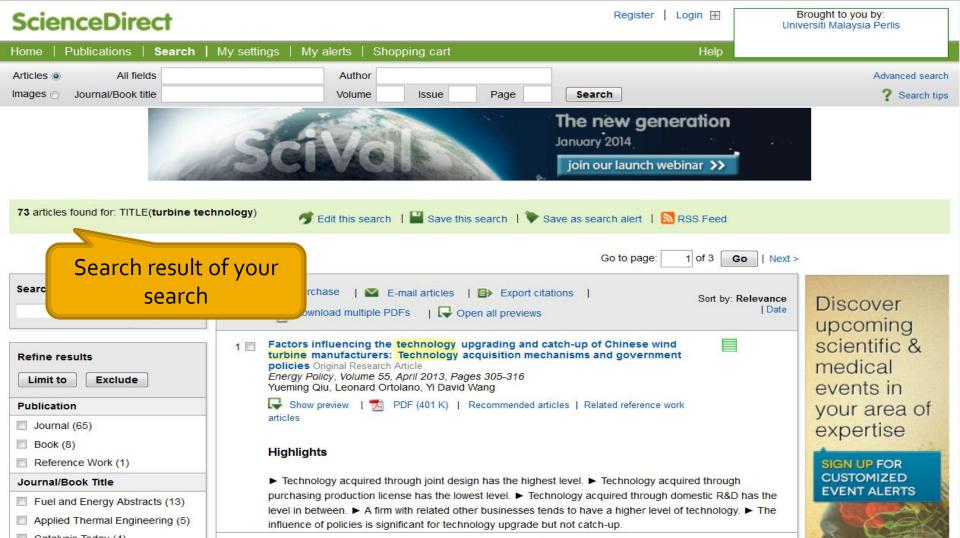


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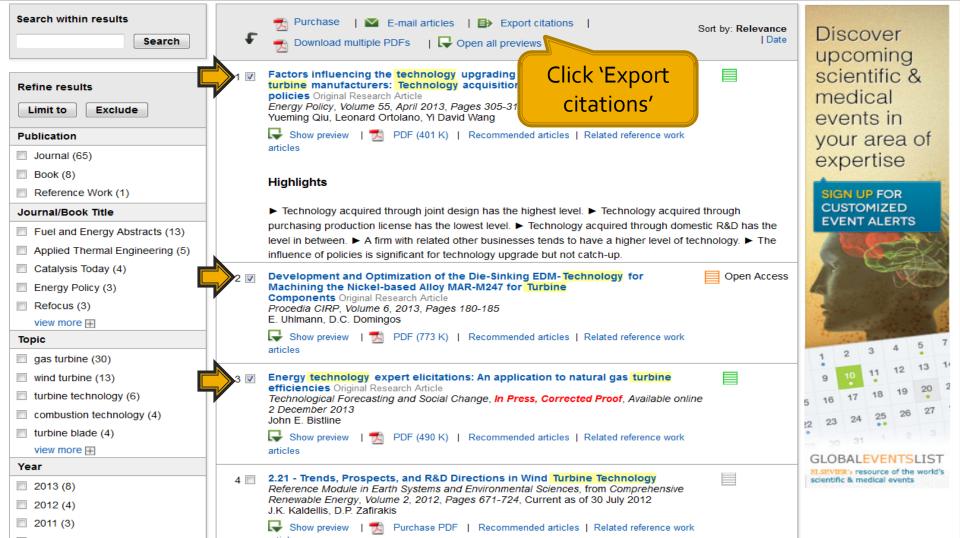
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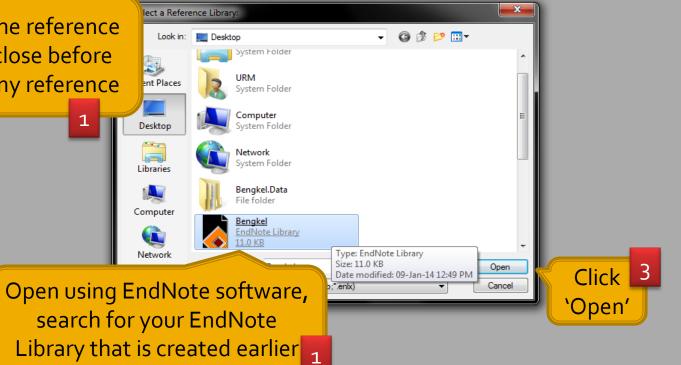


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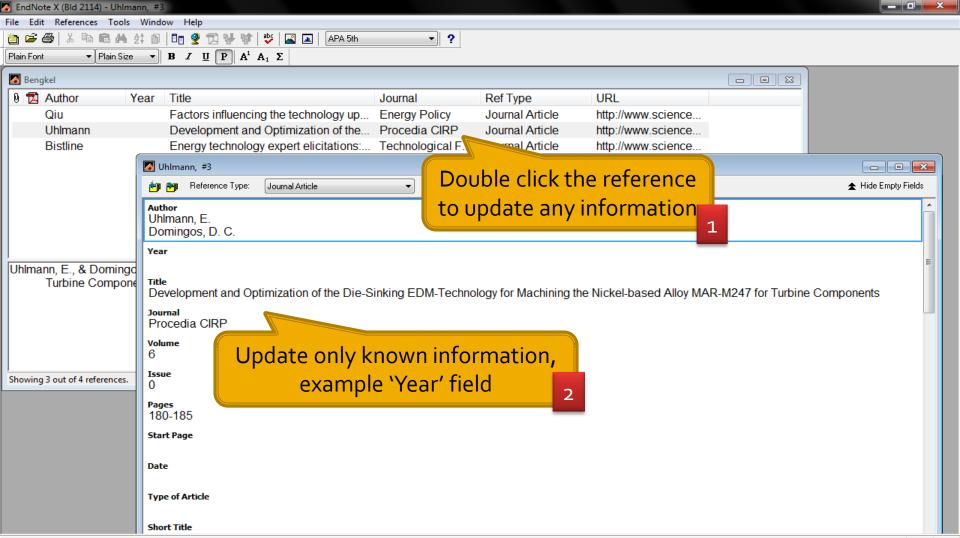


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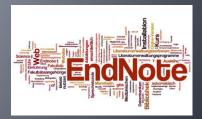


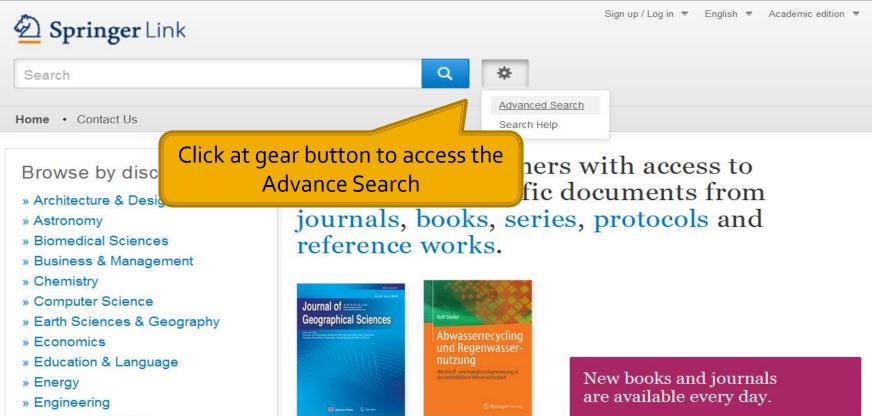
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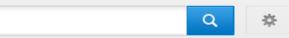
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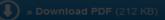
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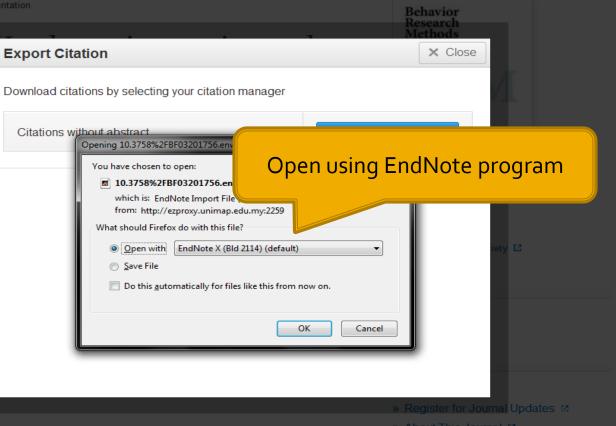
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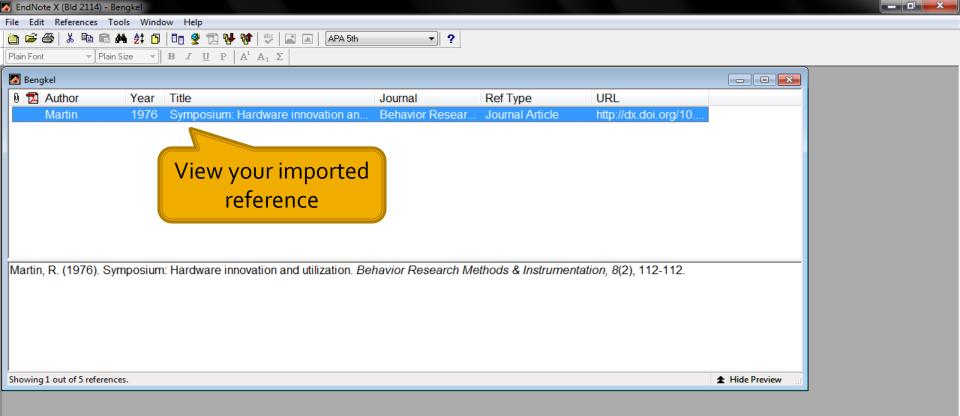
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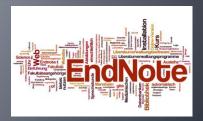
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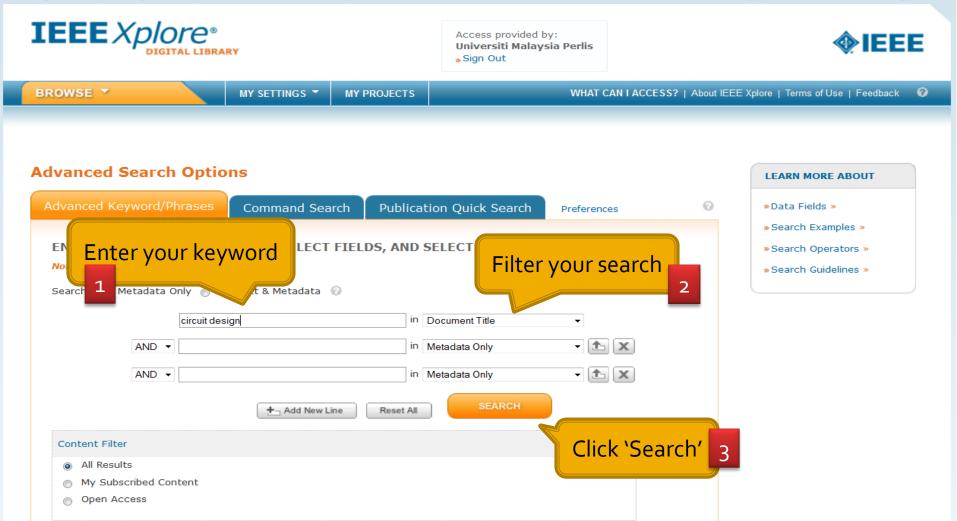
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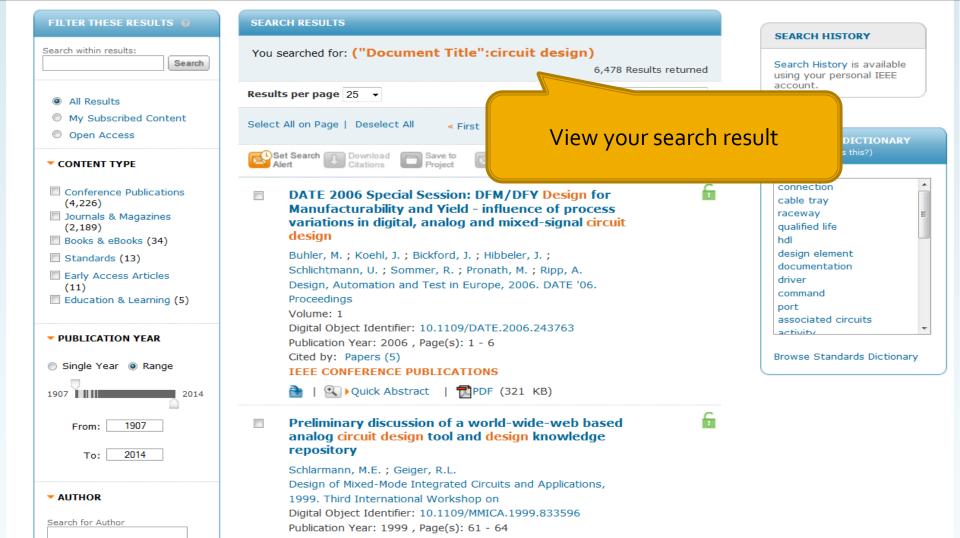






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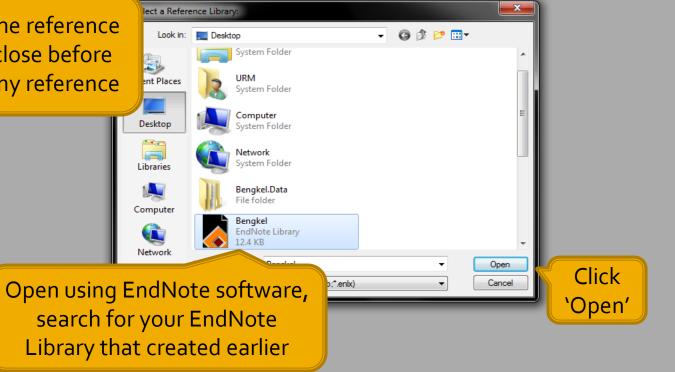


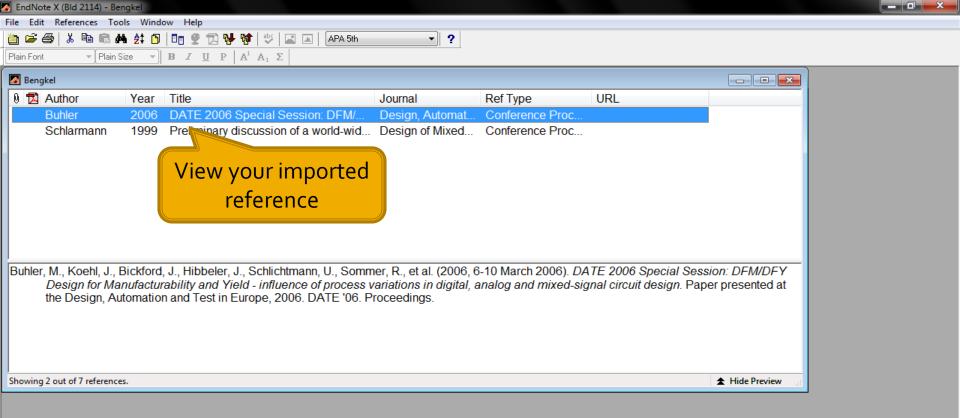




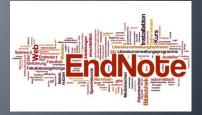
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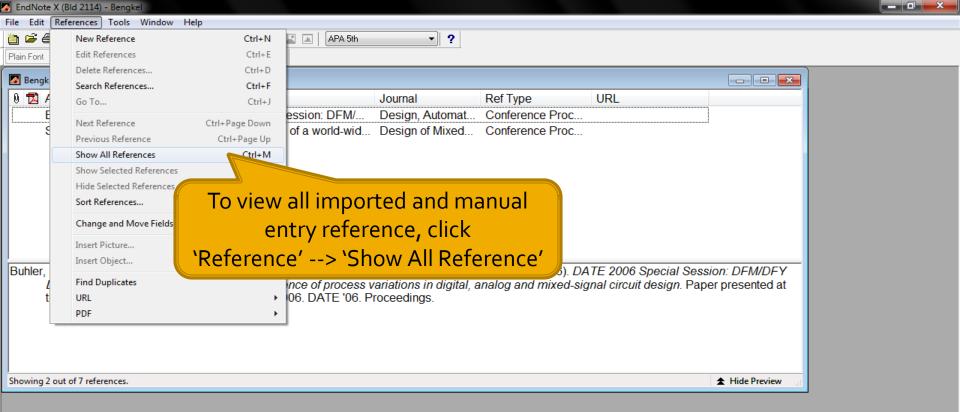
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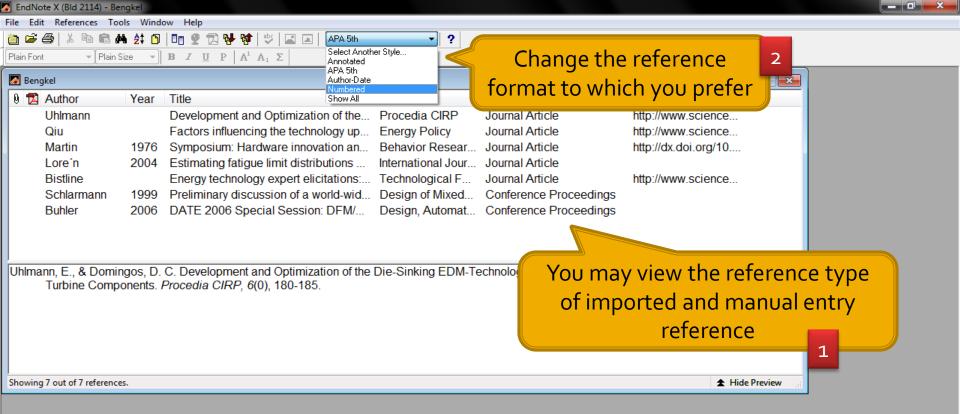




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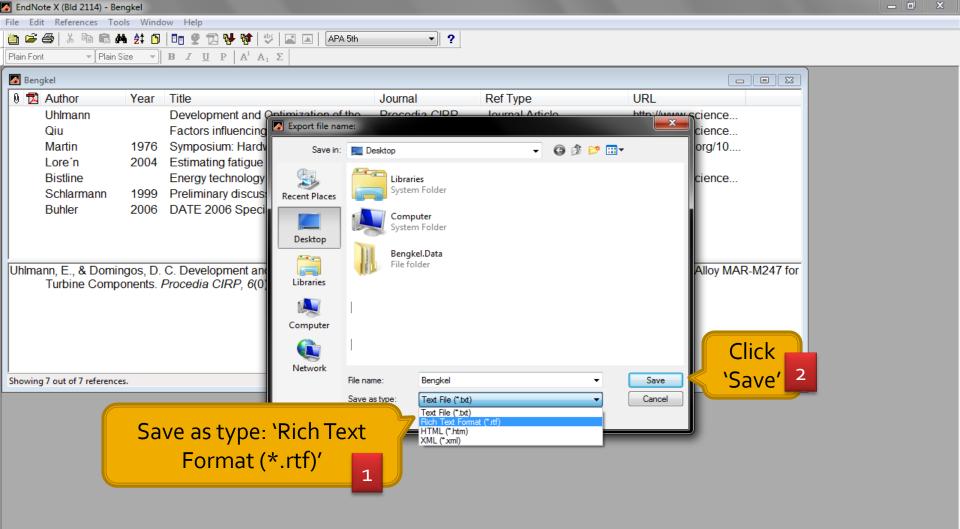


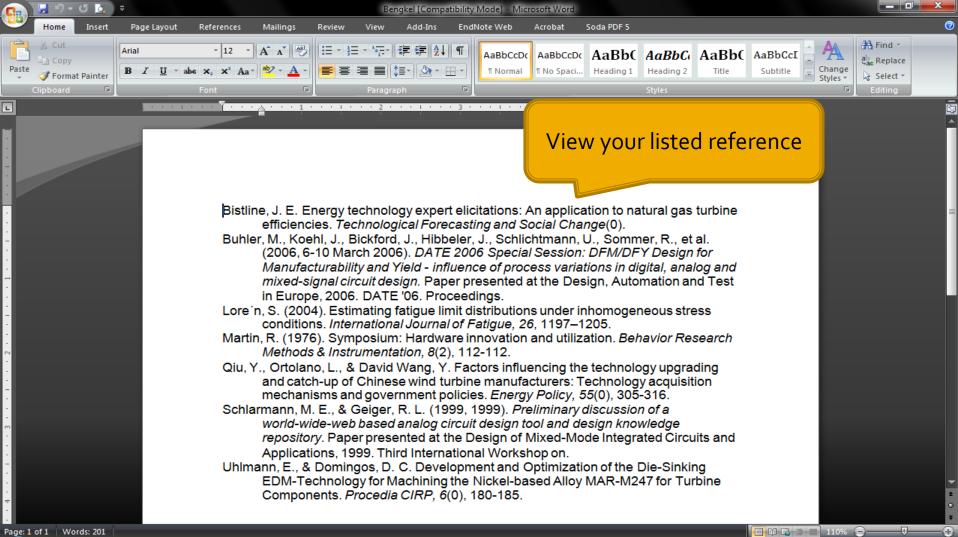


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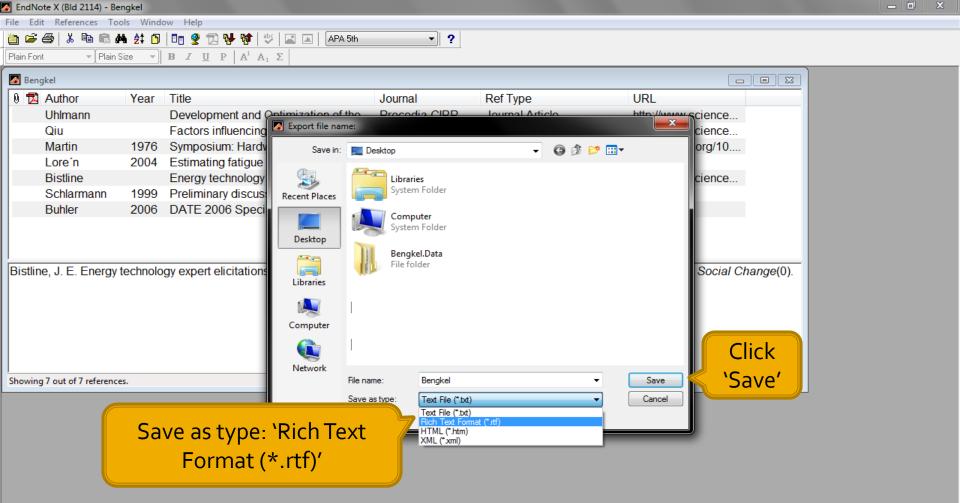
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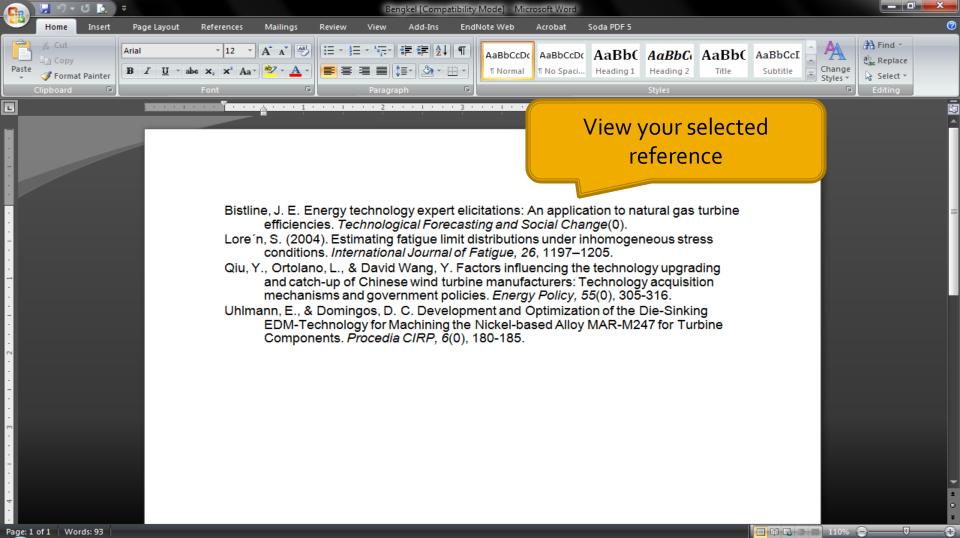
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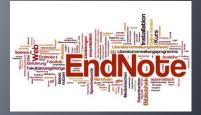
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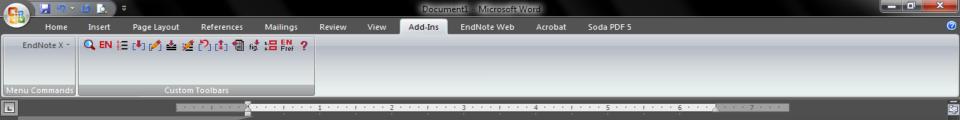
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### Design for Manufacturability and Yield - influence of process variations in digital, analog and mixed-signal circuit design

#### **Chapter 1: Introduction**

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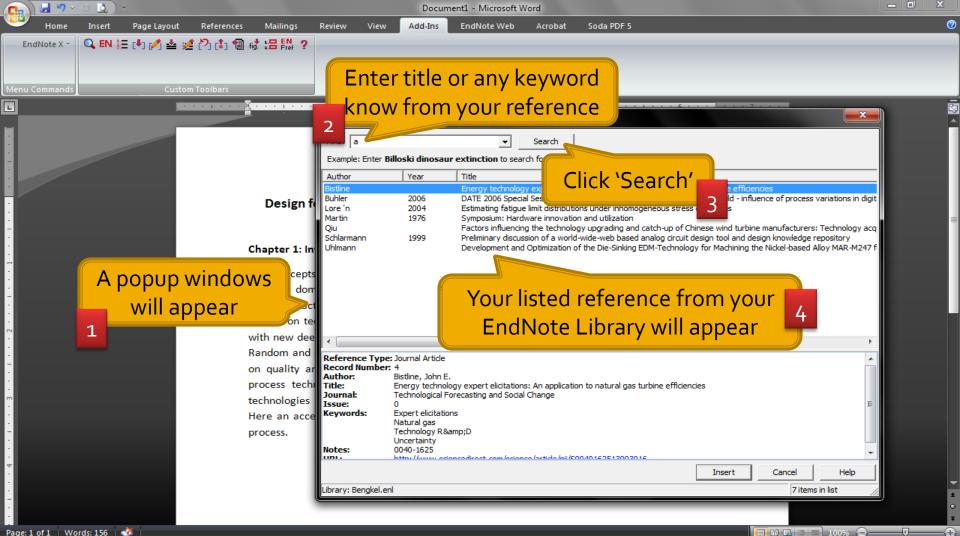
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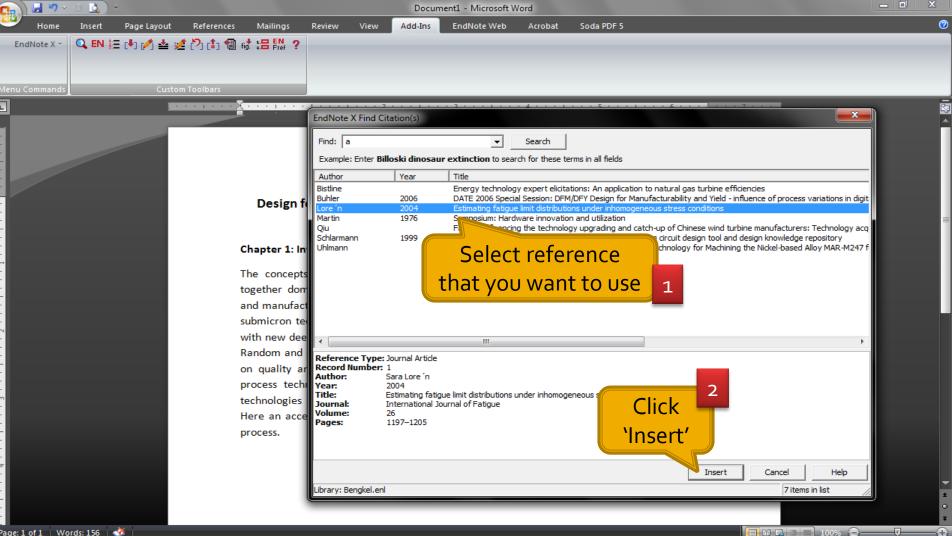
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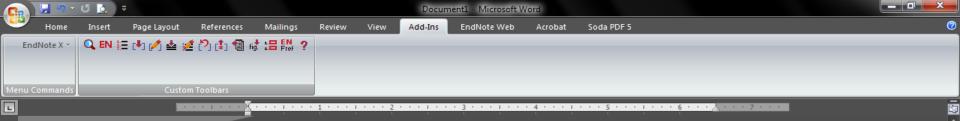
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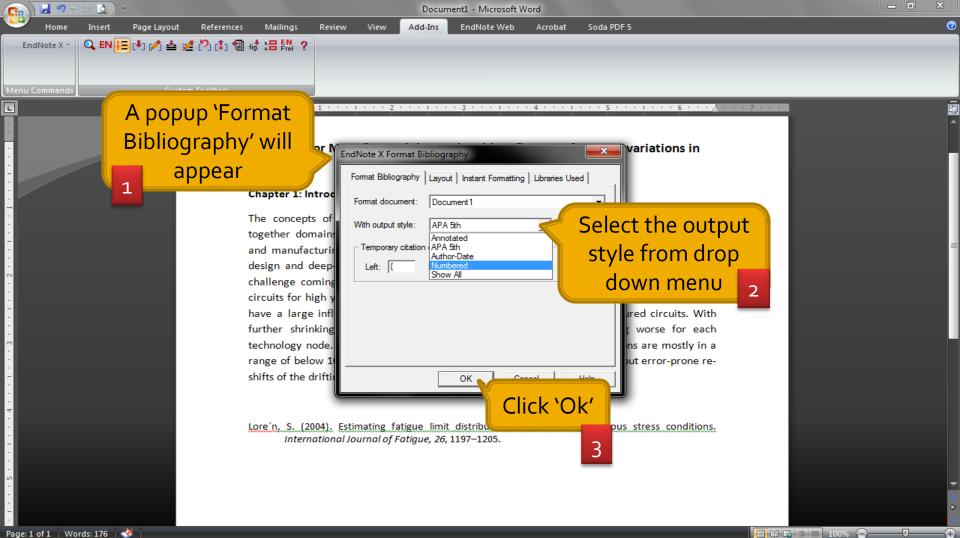
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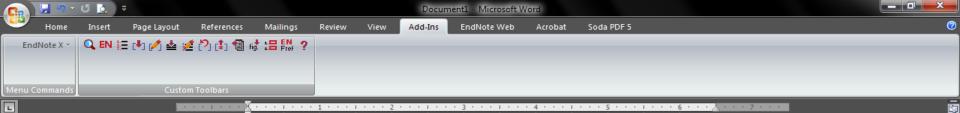
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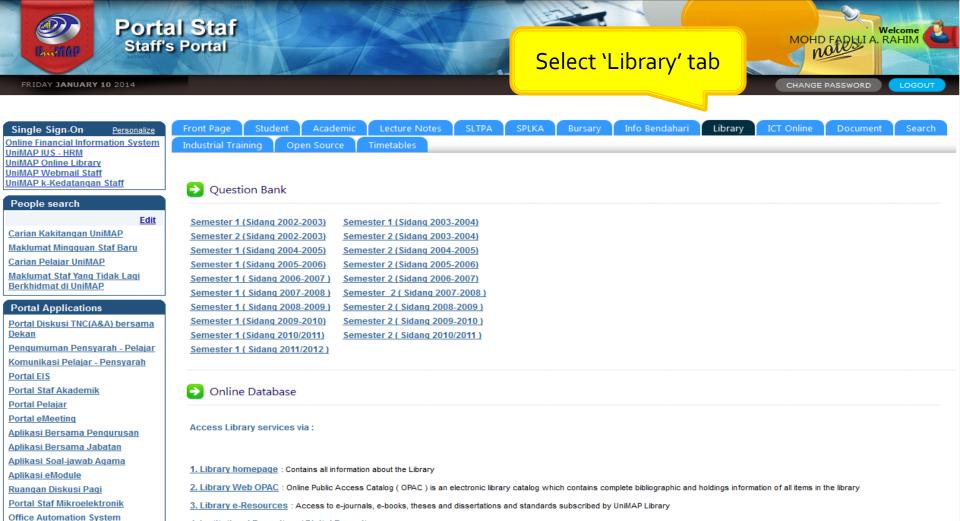
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